

# MOSFET

Metal Oxide Semiconductor Field Effect Transistor

## OptiMOS™

OptiMOS™FD Power-Transistor, 250 V  
IPP220N25NFD

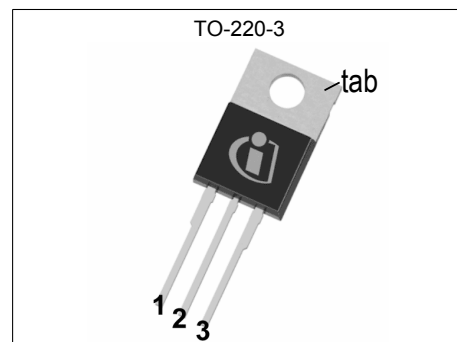
## Data Sheet

Rev. 2.0  
Final

## 1 Description

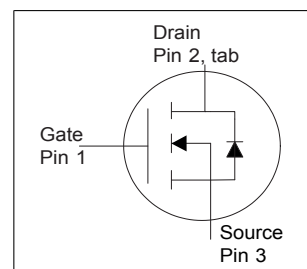
### Features

- N-channel, normal level
- Fast Diode (FD) with reduced  $Q_{rr}$
- Optimized for hard commutation ruggedness
- Very low on-resistance  $R_{DS(on)}$
- 175 °C operating temperature
- Pb-free lead plating; RoHS compliant
- Qualified according to JEDEC <sup>1)</sup> for target application
- Halogen-free according to IEC61249-2-21



**Table 1 Key Performance Parameters**

| Parameter        | Value | Unit |
|------------------|-------|------|
| $V_{DS}$         | 250   | V    |
| $R_{DS(on),max}$ | 22    | mΩ   |
| $I_D$            | 61    | A    |



| Type / Ordering Code | Package    | Marking  | Related Links |
|----------------------|------------|----------|---------------|
| IPP220N25NFD         | PG-TO220-3 | 220N25NF | -             |

<sup>1)</sup> J-STD20 and JESD22

## Table of Contents

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## 2 Maximum ratings

at  $T_j = 25\text{ °C}$ , unless otherwise specified

**Table 2 Maximum ratings**  
at  $25\text{ °C}$

| Parameter                          | Symbol            | Values |      |          | Unit        | Note / Test Condition                                                                                         |
|------------------------------------|-------------------|--------|------|----------|-------------|---------------------------------------------------------------------------------------------------------------|
|                                    |                   | Min.   | Typ. | Max.     |             |                                                                                                               |
| Continuous drain current           | $I_D$             | -      | -    | 61<br>44 | A           | $T_C=25\text{ °C}$<br>$T_C=100\text{ °C}$                                                                     |
| Pulsed drain current <sup>1)</sup> | $I_{D,pulse}$     | -      | -    | 244      | A           | $T_C=25\text{ °C}$                                                                                            |
| Avalanche energy, single pulse     | $E_{AS}$          | -      | -    | 610      | mJ          | $I_D=37\text{ A}$ , $R_{GS}=25\text{ }\Omega$                                                                 |
| Reverse diode peak $dv/dt$         | $dv/dt$           | -      | -    | 60       | kV/ $\mu$ s | $I_D=122\text{ A}$ , $V_{DS}=125\text{ V}$ ,<br>$di/dt=1500\text{ A}/\mu\text{s}$ , $T_{j,max}=175\text{ °C}$ |
| Gate source voltage                | $V_{GS}$          | -20    | -    | 20       | V           | -                                                                                                             |
| Power dissipation                  | $P_{tot}$         | -      | -    | 300      | W           | $T_C=25\text{ °C}$                                                                                            |
| Operating and storage temperature  | $T_j$ , $T_{stg}$ | -55    | -    | 175      | °C          | IEC climatic category;<br>DIN IEC 68-1: 55/175/56                                                             |

## 3 Thermal characteristics

**Table 3 Thermal characteristics**

| Parameter                                                                            | Symbol     | Values |      |      | Unit | Note / Test Condition |
|--------------------------------------------------------------------------------------|------------|--------|------|------|------|-----------------------|
|                                                                                      |            | Min.   | Typ. | Max. |      |                       |
| Thermal resistance, junction - case                                                  | $R_{thJC}$ | -      | 0.3  | 0.5  | K/W  | -                     |
| Thermal resistance, junction - ambient, minimal footprint                            | $R_{thJA}$ | -      | -    | 62   | K/W  | -                     |
| Thermal resistance, junction - ambient, 6 cm <sup>2</sup> cooling area <sup>2)</sup> | $R_{thJA}$ | -      | -    | 40   | K/W  | -                     |

<sup>1)</sup> See figure 3

<sup>2)</sup> Device on 40 mm x 40 mm x 1.5 mm epoxy PCB FR4 with 6 cm<sup>2</sup> (one layer, 70  $\mu$ m thick) copper area for drain connection. PCB is vertical in still air.

## 4 Electrical characteristics

**Table 4 Static characteristics**

| Parameter                        | Symbol        | Values |           |          | Unit          | Note / Test Condition                                                                                                                                         |
|----------------------------------|---------------|--------|-----------|----------|---------------|---------------------------------------------------------------------------------------------------------------------------------------------------------------|
|                                  |               | Min.   | Typ.      | Max.     |               |                                                                                                                                                               |
| Drain-source breakdown voltage   | $V_{(BR)DSS}$ | 250    | -         | -        | V             | $V_{GS}=0\text{ V}$ , $I_D=1\text{ mA}$                                                                                                                       |
| Gate threshold voltage           | $V_{GS(th)}$  | 2      | 3         | 4        | V             | $V_{DS}=V_{GS}$ , $I_D=270\text{ }\mu\text{A}$                                                                                                                |
| Zero gate voltage drain current  | $I_{DSS}$     | -      | 0.1<br>10 | 1<br>100 | $\mu\text{A}$ | $V_{DS}=200\text{ V}$ , $V_{GS}=0\text{ V}$ , $T_J=25\text{ }^\circ\text{C}$<br>$V_{DS}=200\text{ V}$ , $V_{GS}=0\text{ V}$ , $T_J=125\text{ }^\circ\text{C}$ |
| Gate-source leakage current      | $I_{GSS}$     | -      | 1         | 100      | nA            | $V_{GS}=20\text{ V}$ , $V_{DS}=0\text{ V}$                                                                                                                    |
| Drain-source on-state resistance | $R_{DS(on)}$  | -      | 19        | 22       | m $\Omega$    | $V_{GS}=10\text{ V}$ , $I_D=61\text{ A}$                                                                                                                      |
| Gate resistance                  | $R_G$         | -      | 2.5       | 3.8      | $\Omega$      | -                                                                                                                                                             |
| Transconductance                 | $g_{fs}$      | 60     | 120       | -        | S             | $ V_{DS} >2 I_D /R_{DS(on)max}$ , $I_D=61\text{ A}$                                                                                                           |

**Table 5 Dynamic characteristics**

| Parameter                    | Symbol       | Values |      |      | Unit | Note / Test Condition                                                                                 |
|------------------------------|--------------|--------|------|------|------|-------------------------------------------------------------------------------------------------------|
|                              |              | Min.   | Typ. | Max. |      |                                                                                                       |
| Input capacitance            | $C_{iss}$    | -      | 5320 | 7076 | pF   | $V_{GS}=0\text{ V}$ , $V_{DS}=125\text{ V}$ , $f=1\text{ MHz}$                                        |
| Output capacitance           | $C_{oss}$    | -      | 299  | 398  | pF   | $V_{GS}=0\text{ V}$ , $V_{DS}=125\text{ V}$ , $f=1\text{ MHz}$                                        |
| Reverse transfer capacitance | $C_{rss}$    | -      | 6    | 13   | pF   | $V_{GS}=0\text{ V}$ , $V_{DS}=125\text{ V}$ , $f=1\text{ MHz}$                                        |
| Turn-on delay time           | $t_{d(on)}$  | -      | 14   | -    | ns   | $V_{DD}=125\text{ V}$ , $V_{GS}=10\text{ V}$ , $I_D=30.5\text{ A}$ ,<br>$R_{G,ext}=1.6\text{ }\Omega$ |
| Rise time                    | $t_r$        | -      | 10   | -    | ns   | $V_{DD}=125\text{ V}$ , $V_{GS}=10\text{ V}$ , $I_D=30.5\text{ A}$ ,<br>$R_{G,ext}=1.6\text{ }\Omega$ |
| Turn-off delay time          | $t_{d(off)}$ | -      | 26   | -    | ns   | $V_{DD}=125\text{ V}$ , $V_{GS}=10\text{ V}$ , $I_D=30.5\text{ A}$ ,<br>$R_{G,ext}=1.6\text{ }\Omega$ |
| Fall time                    | $t_f$        | -      | 8    | -    | ns   | $V_{DD}=125\text{ V}$ , $V_{GS}=10\text{ V}$ , $I_D=30.5\text{ A}$ ,<br>$R_{G,ext}=1.6\text{ }\Omega$ |

**Table 6 Gate charge characteristics <sup>1)</sup>**

| Parameter             | Symbol        | Values |      |      | Unit | Note / Test Condition                                                        |
|-----------------------|---------------|--------|------|------|------|------------------------------------------------------------------------------|
|                       |               | Min.   | Typ. | Max. |      |                                                                              |
| Gate to source charge | $Q_{gs}$      | -      | 24   | -    | nC   | $V_{DD}=125\text{ V}$ , $I_D=61\text{ A}$ , $V_{GS}=0\text{ to }10\text{ V}$ |
| Gate to drain charge  | $Q_{gd}$      | -      | 7    | -    | nC   | $V_{DD}=125\text{ V}$ , $I_D=61\text{ A}$ , $V_{GS}=0\text{ to }10\text{ V}$ |
| Switching charge      | $Q_{sw}$      | -      | 16   | -    | nC   | $V_{DD}=125\text{ V}$ , $I_D=61\text{ A}$ , $V_{GS}=0\text{ to }10\text{ V}$ |
| Gate charge total     | $Q_g$         | -      | 65   | 86   | nC   | $V_{DD}=125\text{ V}$ , $I_D=61\text{ A}$ , $V_{GS}=0\text{ to }10\text{ V}$ |
| Gate plateau voltage  | $V_{plateau}$ | -      | 4.5  | -    | V    | $V_{DD}=125\text{ V}$ , $I_D=61\text{ A}$ , $V_{GS}=0\text{ to }10\text{ V}$ |
| Output charge         | $Q_{oss}$     | -      | 144  | -    | nC   | $V_{DD}=125\text{ V}$ , $V_{GS}=0\text{ V}$                                  |

<sup>1)</sup> See "Gate charge waveforms" for parameter definition

**Table 7 Reverse diode**

| Parameter                                    | Symbol        | Values |      |      | Unit | Note / Test Condition                                                         |
|----------------------------------------------|---------------|--------|------|------|------|-------------------------------------------------------------------------------|
|                                              |               | Min.   | Typ. | Max. |      |                                                                               |
| Diode continuous forward current             | $I_S$         | -      | -    | 61   | A    | $T_C=25\text{ °C}$                                                            |
| Diode pulse current <sup>1)</sup>            | $I_{S,pulse}$ | -      | -    | 244  | A    | $T_C=25\text{ °C}$                                                            |
| Diode hard commutation current <sup>2)</sup> | $I_{S,hard}$  | -      | -    | 122  | A    | -                                                                             |
| Diode forward voltage                        | $V_{SD}$      | -      | 1    | 1.2  | V    | $V_{GS}=0\text{ V}$ , $I_F=61\text{ A}$ , $T_J=25\text{ °C}$                  |
| Reverse recovery time                        | $t_{rr}$      | -      | 128  | 257  | ns   | $V_R=100\text{ V}$ , $I_F=42.7\text{ A}$ , $di_F/dt=100\text{ A}/\mu\text{s}$ |
| Reverse recovery charge                      | $Q_{rr}$      | -      | 623  | -    | nC   | $V_R=100\text{ V}$ , $I_F=42.7\text{ A}$ , $di_F/dt=100\text{ A}/\mu\text{s}$ |

<sup>1)</sup> Diode pulse current is defined by thermal and/or package limits

<sup>2)</sup> Maximum allowed hard-commutated current through diode at  $di/dt=1500\text{ A}/\mu\text{s}$

## 5 Electrical characteristics diagrams

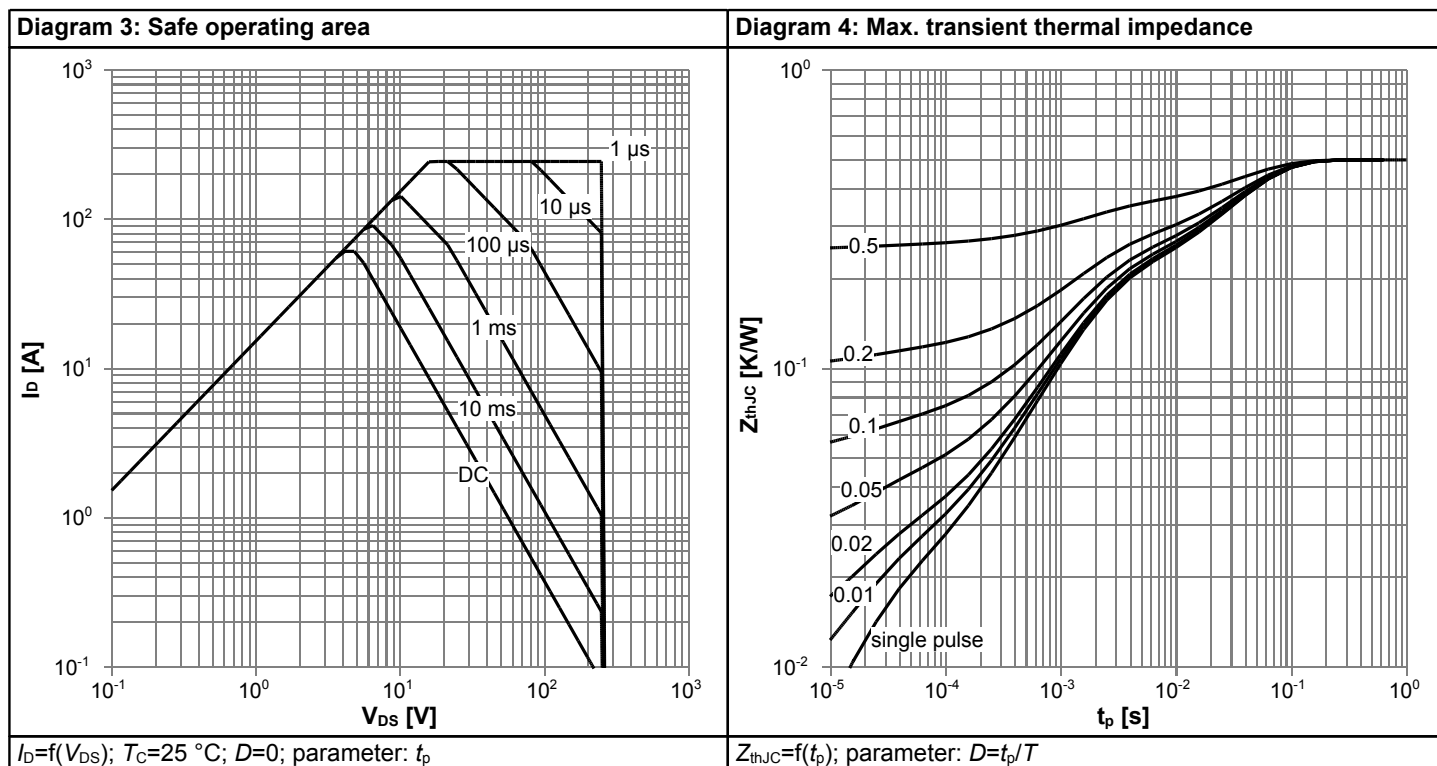
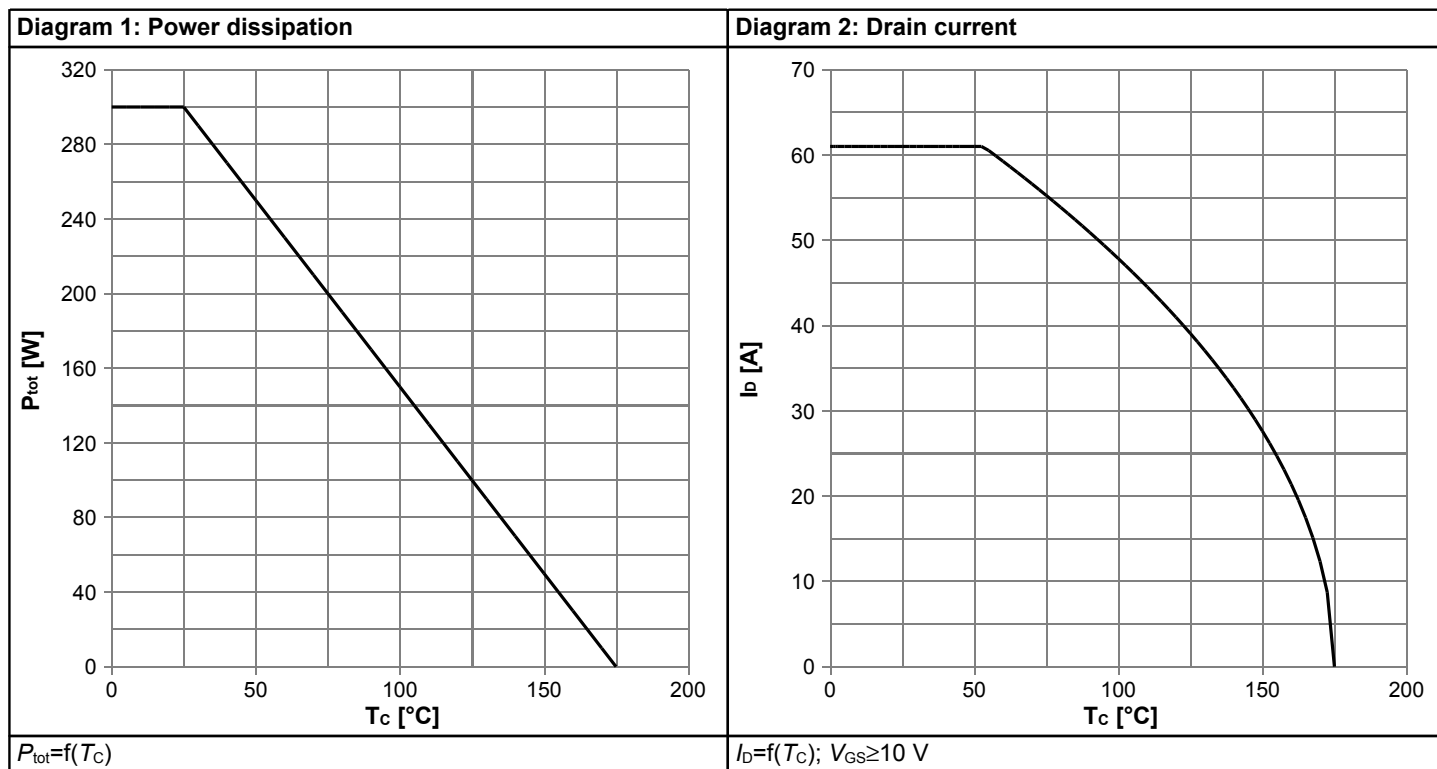


Diagram 5: Typ. output characteristics

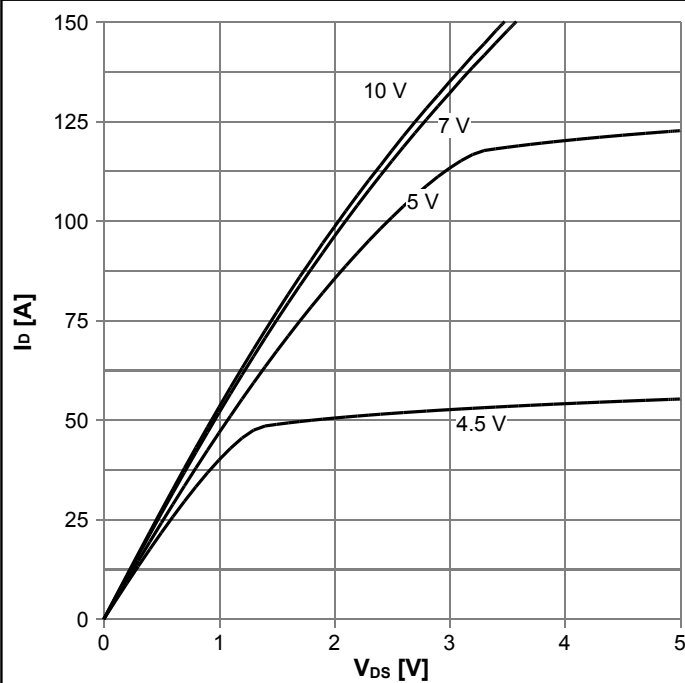

 $I_D = f(V_{DS}); T_j = 25^\circ\text{C}; \text{parameter: } V_{GS}$ 

Diagram 6: Typ. drain-source on resistance

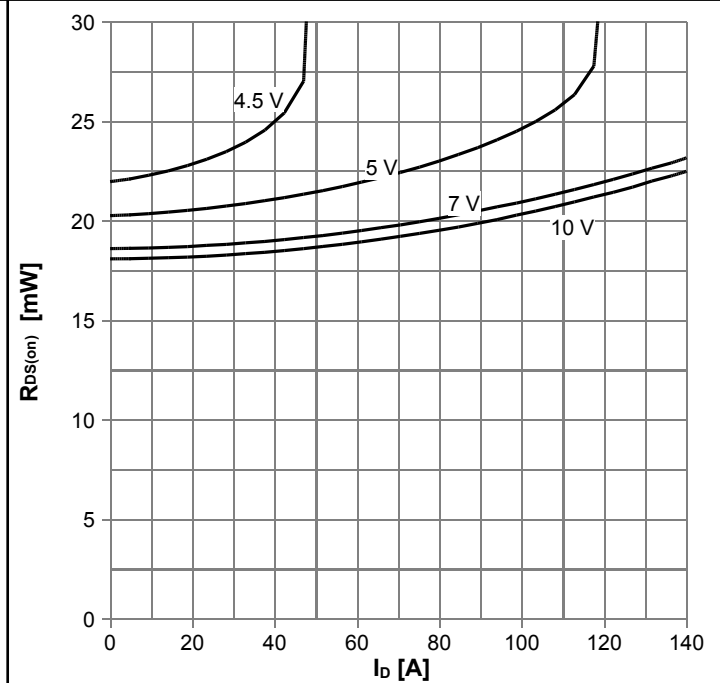

 $R_{DS(on)} = f(I_D); T_j = 25^\circ\text{C}; \text{parameter: } V_{GS}$ 

Diagram 7: Typ. transfer characteristics

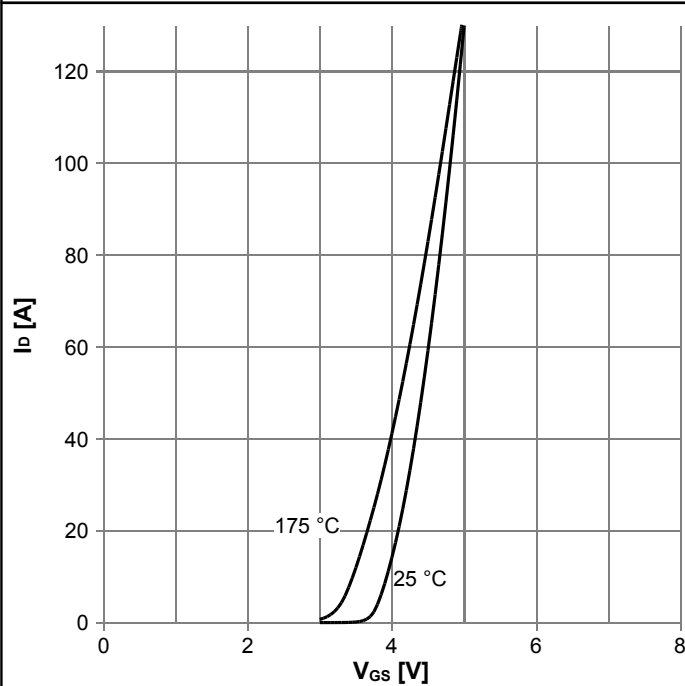

 $I_D = f(V_{GS}); |V_{DS}| > 2|I_D|R_{DS(on)max}; \text{parameter: } T_j$ 

Diagram 8: Typ. forward transconductance

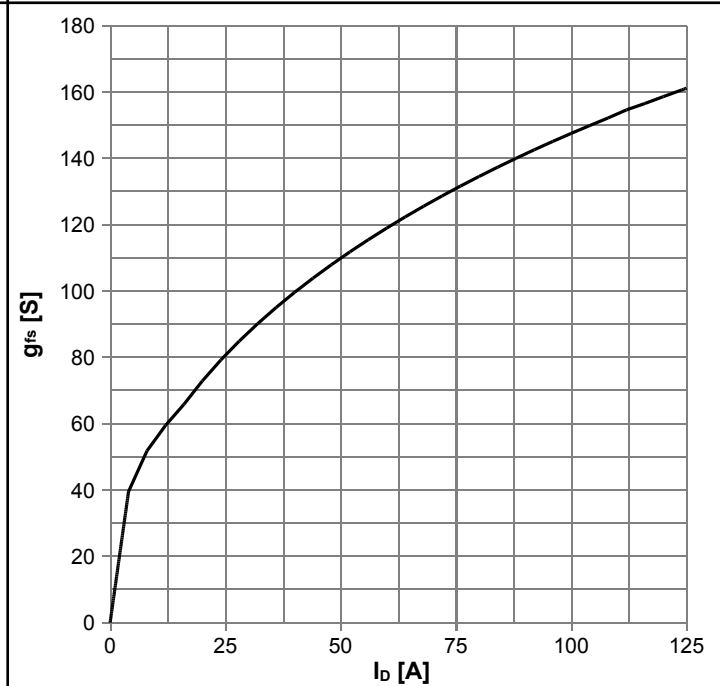
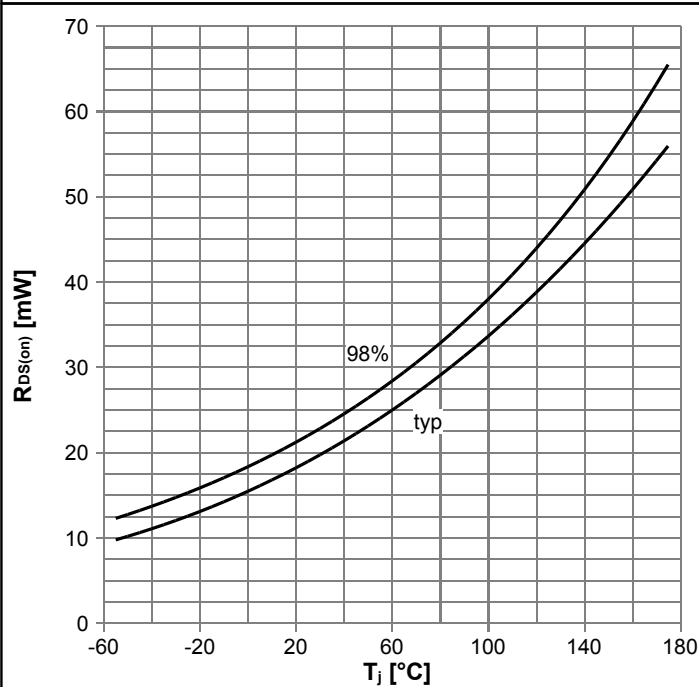
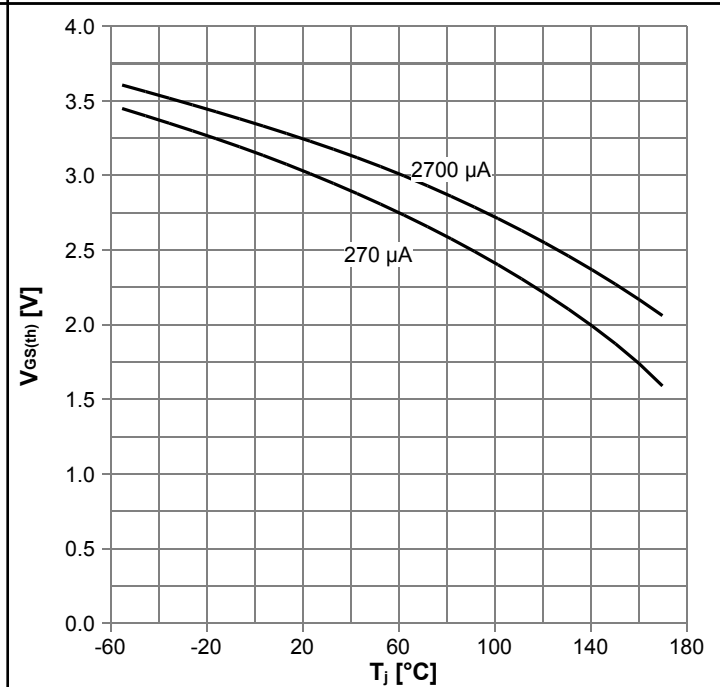

 $g_{fs} = f(I_D); T_j = 25^\circ\text{C}$

Diagram 9: Drain-source on-state resistance



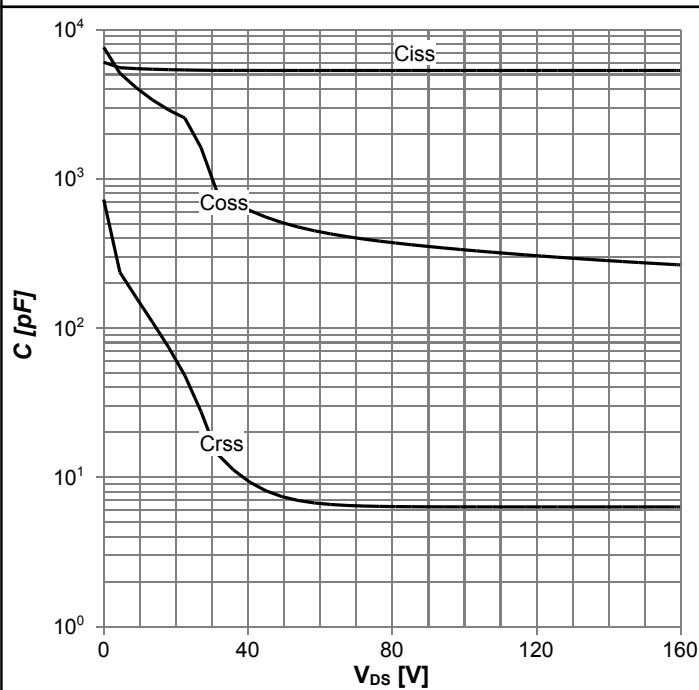
$$R_{DS(on)} = f(T_j); I_D = 61 \text{ A}; V_{GS} = 10 \text{ V}$$

Diagram 10: Typ. gate threshold voltage



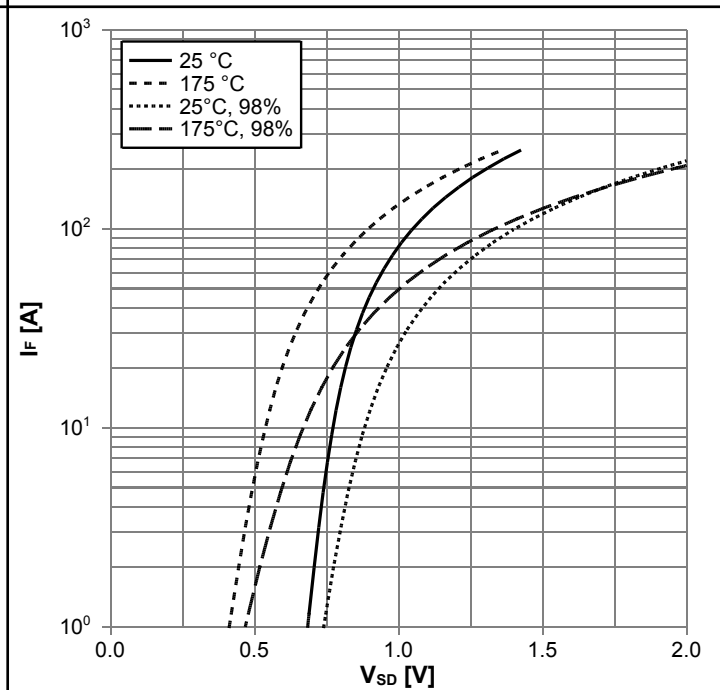
$$V_{GS(th)} = f(T_j); V_{GS} = V_{DS}; \text{parameter: } I_D$$

Diagram 11: Typ. capacitances



$$C = f(V_{DS}); V_{GS} = 0 \text{ V}; f = 1 \text{ MHz}$$

Diagram 12: Forward characteristics of reverse diode



$$I_F = f(V_{SD}); \text{parameter: } T_j$$

Diagram 13: Avalanche characteristics

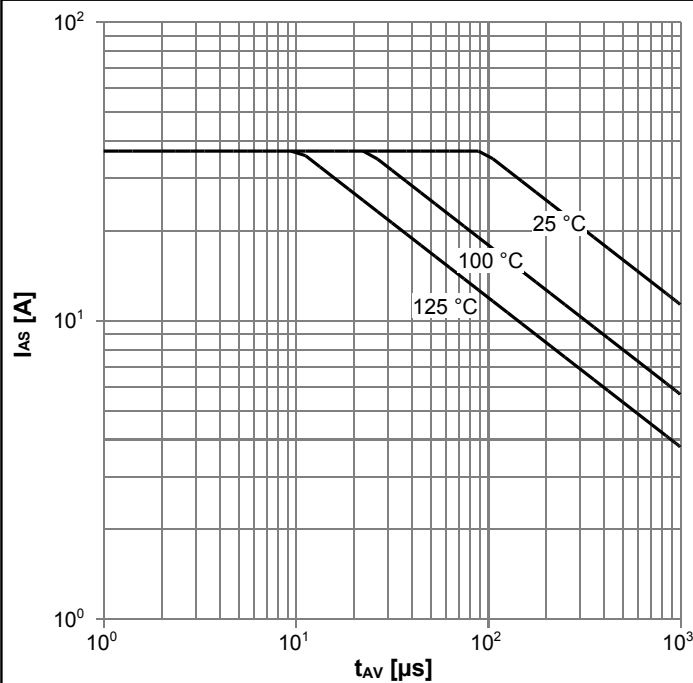

 $I_{AS}=f(t_{AV}); R_{GS}=25\ \Omega; \text{parameter: } T_{j(\text{start})}$ 

Diagram 14: Typ. gate charge

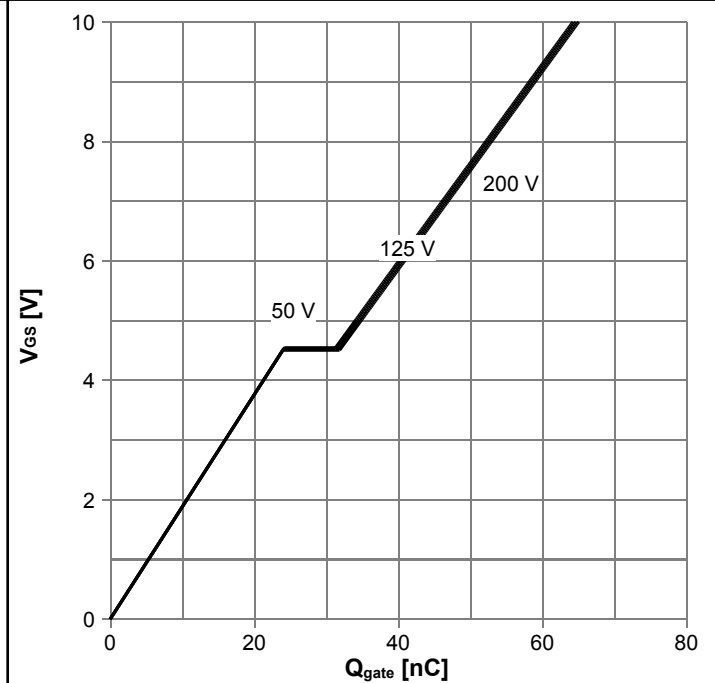
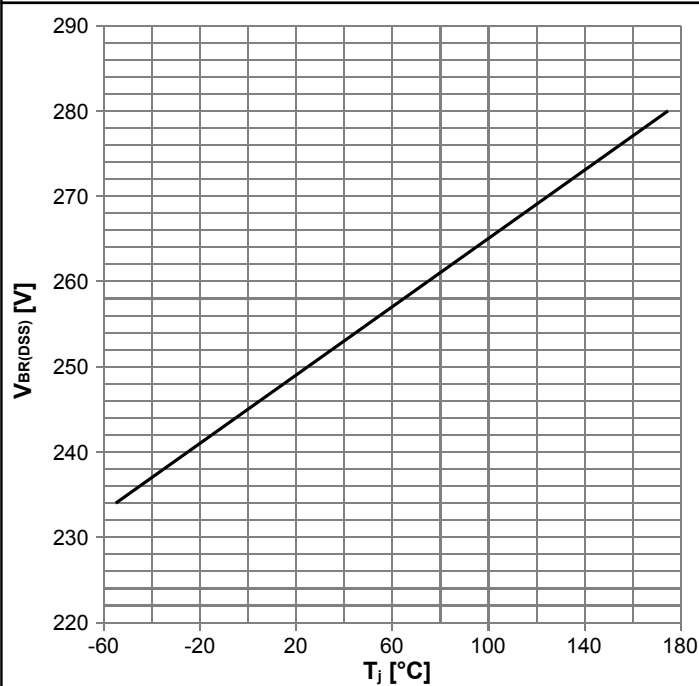
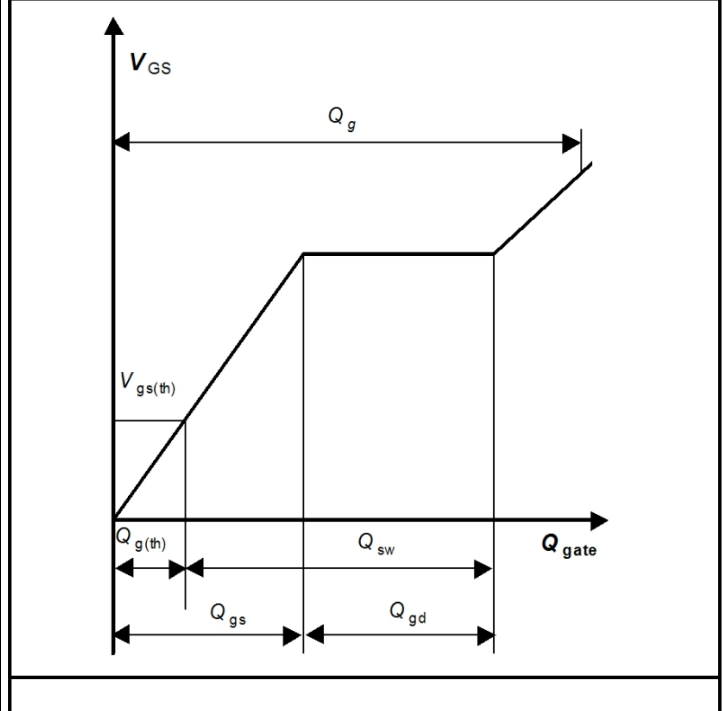

 $V_{GS}=f(Q_{\text{gate}}); I_D=61\ \text{A pulsed}; \text{parameter: } V_{DD}$ 

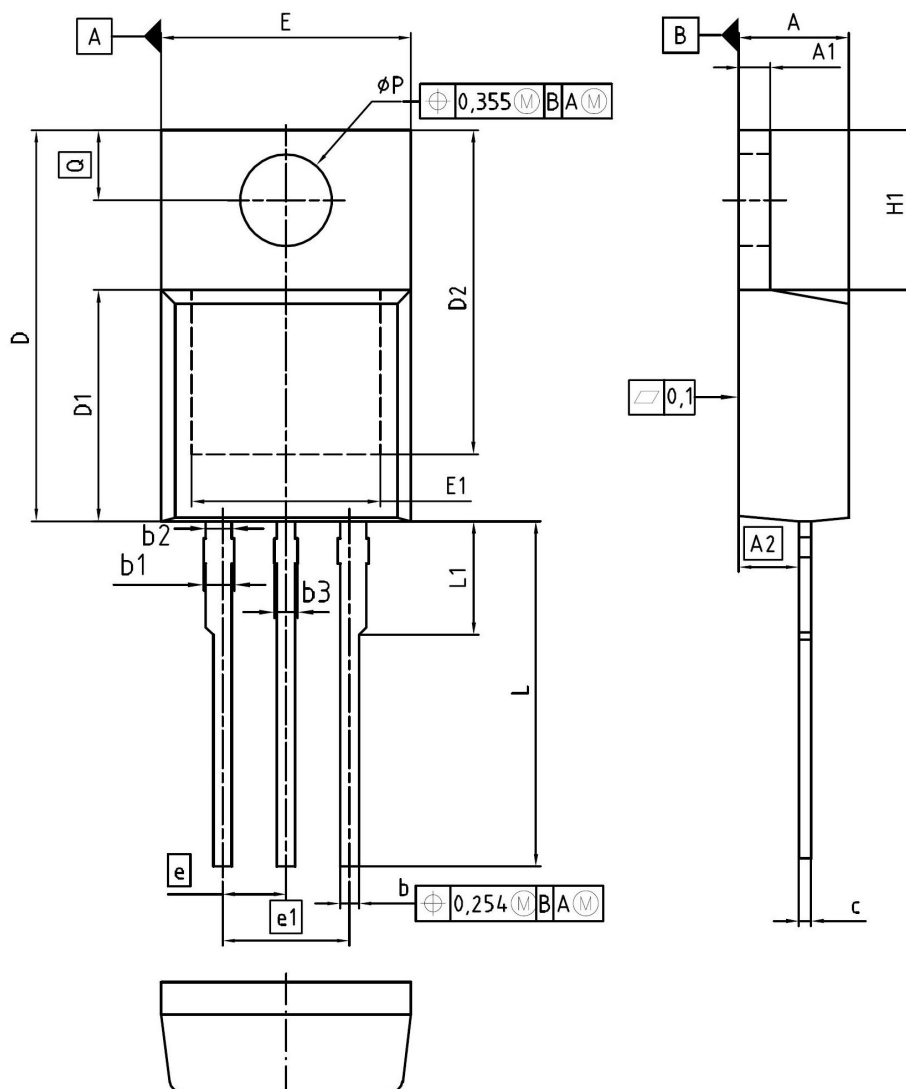
Diagram 15: Drain-source breakdown voltage


 $V_{BR(DSS)}=f(T_J); I_D=1\ \text{mA}$ 

Gate charge waveforms



## 6 Package Outlines



| DIM      | MILLIMETERS |       | INCHES |       |
|----------|-------------|-------|--------|-------|
|          | MIN         | MAX   | MIN    | MAX   |
| A        | 4.30        | 4.57  | 0.169  | 0.180 |
| A1       | 1.17        | 1.40  | 0.046  | 0.055 |
| A2       | 2.15        | 2.72  | 0.085  | 0.107 |
| b        | 0.65        | 0.86  | 0.026  | 0.034 |
| b1       | 0.95        | 1.40  | 0.037  | 0.055 |
| b2       | 0.95        | 1.15  | 0.037  | 0.045 |
| b3       | 0.65        | 1.15  | 0.026  | 0.045 |
| c        | 0.33        | 0.60  | 0.013  | 0.024 |
| D        | 14.81       | 15.95 | 0.583  | 0.628 |
| D1       | 8.51        | 9.45  | 0.335  | 0.372 |
| D2       | 12.19       | 13.10 | 0.480  | 0.516 |
| E        | 9.70        | 10.36 | 0.382  | 0.408 |
| E1       | 6.50        | 8.60  | 0.256  | 0.339 |
| e        | 2.54        |       | 0.100  |       |
| e1       | 5.08        |       | 0.200  |       |
| N        | 3           |       | 3      |       |
| H1       | 5.90        | 6.90  | 0.232  | 0.272 |
| L        | 13.00       | 14.00 | 0.512  | 0.551 |
| L1       | -           | 4.80  | -      | 0.189 |
| $\phi P$ | 3.60        | 3.89  | 0.142  | 0.153 |
| Q        | 2.60        | 3.00  | 0.102  | 0.118 |

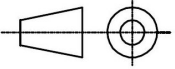
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| DOCUMENT NO.<br>Z8B00003318                                                                                  |
| SCALE<br>0 2.5 5mm                                                                                           |
| EUROPEAN PROJECTION<br> |
| ISSUE DATE<br>30-07-2009                                                                                     |
| REVISION<br>06                                                                                               |

Figure 1 Outline PG-TO220-3, dimensions in mm/inches

## Revision History

IPP220N25NFD

**Revision: 2014-02-06, Rev. 2.0**

Previous Revision

| Revision | Date       | Subjects (major changes since last revision) |
|----------|------------|----------------------------------------------|
| 2.0      | 2014-02-06 | Release of final version                     |

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